

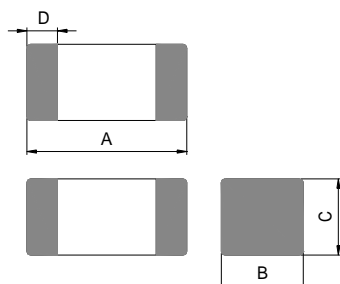
# High Current Ferrite Chip Bead(Lead Free)

HCB-Series

## 1.Features

- 1.Monolithic inorganic material construction.
- 2.Low DC resistance structure of electrode to prevent wasteful electric power consumption.
- 3.Closed magnetic circuit avoids crosstalk.
- 4.Suitable for flow and reflow soldering.
- 5.Shapes and dimensions follow E.I.A. spec.
- 6.Available in various sizes.
- 7.Excellent solderability and heat resistance.
- 8.High reliability.
- 9.This component is compliant with RoHS legislation and also support lead-free soldering.

## 2.Dimensions



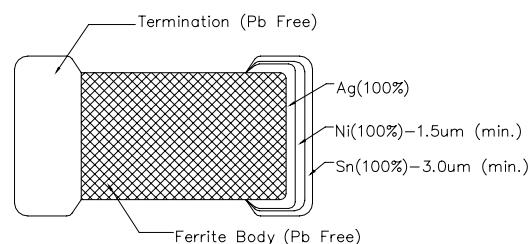
Chip size				
Size	A(mm)	B(mm)	C(mm)	D(mm)
1608	1.6±0.15	0.8±0.15	0.8±0.15	0.3±0.2
2012	2.0±0.2	1.25±0.2	0.85±0.2	0.5±0.3

## 3.Part Numbering



A: Series  
 B: Dimension  
 C: Material  
 D: Impedance  
 E: Packaging  
 F: Rated Current

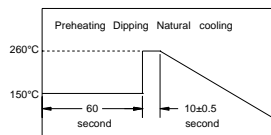
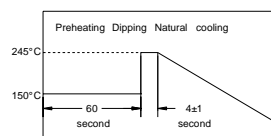
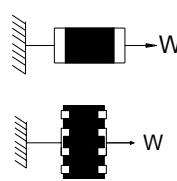
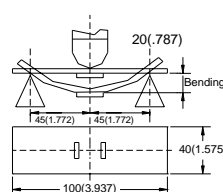
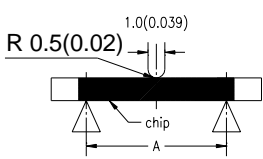
L x W  
 Lead Free Material  
 121=120  
 T=Taping and Reel, B=Bulk(Bags)  
 20=2000mA



## 4.Specification

Part Number	Impedance ( )	Test Frequency (MHz)	DC Resistance ( ) max.	Rated Current (mA)
HCB1608KF-300T30	30±25%	100	0.04	3000
HCB1608KF-800T30	80±25%	100	0.04	3000
HCB1608KF-121T20	120±25%	100	0.10	2000
HCB1608KF-151T20	150±25%	100	0.10	2000
HCB1608KF-221T20	220±25%	100	0.10	2000
HCB1608KF-301T10	300±25%	100	0.20	1000
HCB1608KF-471T10	470±25%	100	0.20	1000
HCB1608KF-601T10	600±25%	100	0.20	1000
HCB2012KF-300T30	30±25%	100	0.04	3000
HCB2012KF-800T30	80±25%	100	0.04	3000
HCB2012KF-121T20	120±25%	100	0.10	2000
HCB2012KF-151T20	150±25%	100	0.10	2000
HCB2012KF-221T20	220±25%	100	0.10	2000
HCB2012KF-301T10	300±25%	100	0.20	1000
HCB2012KF-471T10	470±25%	100	0.20	1000
HCB2012KF-601T10	600±25%	100	0.20	1000

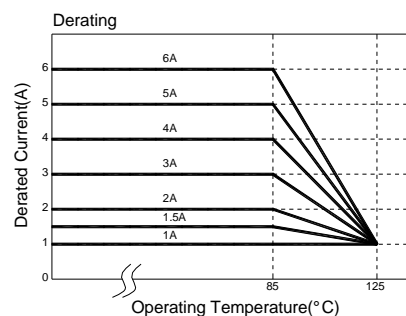
## 5. Reliability and Test Condition

Item	Performance										Test Condition																																		
Series No.	FCB	FCM	HCB	HPB	HFB	FCA	FCI	FHI	FCH	HCI	--																																		
Operating Temperature	-55~+125 (Including self-temperature rise)						-40~+85 (Including self-temperaturerise)				--																																		
Storage Temperature	-55~+125						-40~+85				--																																		
Impedance (Z)	Refer to standard electrical characteristics list										HP4291A, HP4287A+16092A																																		
Inductance (Ls)																																													
Q Factor																																													
DC Resistance											HP4338B																																		
Rated Current											**																																		
Temperature Rise Test	30    max. (    T )										1. Applied the allowed DC current. 2. Temperature measured by digital surface thermometer.																																		
Solder heat Resistance	Appearance: No significant abnormality. Impedance change: Within ± 30%.					No mechanical damage. Remaining terminal electrode:70% min.					Preheat: 150    ,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder temperature: 260±5 Flux for lead free: rosin Dip time: 10±0.5sec. <div></div>																																		
Solderability	More than 90% of the terminal electrode should be covered with solder.					<div></div>					Preheat: 150    ,60sec. Solder: Sn-Ag3.0-Cu0.5 Solder temperature: 245±5 Flux for lead free: rosin Dip time: 4±1sec.																																		
Terminal strength	The terminal electrode and the dielectric must not be damaged by the forces applied on the right conditions. <div></div>					For FCB FCM HCB HPB HFB FCI FHI FCH HCI: <table><tr><td>Size</td><td>Force (Kgf)</td><td>Time(sec)</td></tr><tr><td>1005</td><td>0.2</td><td></td></tr><tr><td>1608</td><td>0.5</td><td></td></tr><tr><td>2012</td><td>0.6</td><td></td></tr><tr><td>3216</td><td>1.0</td><td>&gt;25</td></tr><tr><td>3225</td><td>1.0</td><td></td></tr><tr><td>4516</td><td>1.0</td><td></td></tr><tr><td>4532</td><td>1.5</td><td></td></tr><tr><td>5750</td><td>2.0</td><td></td></tr></table> For FCA: <table><tr><td>Size</td><td>Force (Kgf)</td><td>Time(sec)</td></tr><tr><td>3216</td><td>0.5</td><td>&gt;25</td></tr></table>							Size	Force (Kgf)	Time(sec)	1005	0.2		1608	0.5		2012	0.6		3216	1.0	>25	3225	1.0		4516	1.0		4532	1.5		5750	2.0		Size	Force (Kgf)	Time(sec)	3216	0.5	>25
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Bending Strength	The ferrite should not be damaged by Forces applied on the right condition. <div></div>					<table><tr><td>Size</td><td>mm(inches)</td><td>P-Kgf</td></tr><tr><td>1608</td><td>0.80(0.033)</td><td>0.3</td></tr><tr><td>2012</td><td>1.40(0.055)</td><td>1.0</td></tr><tr><td>FCA3216</td><td>2.00(0.079)</td><td>1.5</td></tr><tr><td>3216</td><td>2.00(0.079)</td><td>2.5</td></tr><tr><td>4516</td><td></td><td></td></tr><tr><td>4532</td><td>2.70(0.106)</td><td>2.5</td></tr><tr><td>5750</td><td></td><td></td></tr></table>							Size	mm(inches)	P-Kgf	1608	0.80(0.033)	0.3	2012	1.40(0.055)	1.0	FCA3216	2.00(0.079)	1.5	3216	2.00(0.079)	2.5	4516			4532	2.70(0.106)	2.5	5750											
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Random Vibration Test	Appearance: Cracking, shipping and any other defects harmful to the characteristics should not be allowed. Impedance: within±30%					Frequency: 10-55-10Hz for 1 min. Amplitude: 1.52mm Directions and times: X, Y, Z directions for 2 hours. A period of 2 hours in each of 3 mutually perpendicular directions (Total 6 hours).																																							

Item	Performance	Test Condition
Loading at High Temperature	Appearance: no damage.	Temperature: 125±5 (bead), 85±5 (inductor) Applied current: rated current. Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Humidity	Impedance: within±30%of initial value. Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI FCH) Q: within±20%of initial value. (HCI )	Humidity: 90~95%RH. Temperature: 40±2 (FCI FHI FCH) Temperature: 60±2 (HCI) Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Thermal shock	Appearance: no damage. Impedance: within±30%of initial value. Inductance: within±10%of initial value. Q: within±30%of initial value. (FCI FHI FCH) Q: within±20%of initial value. (HCI)	For FCB FCM HCB HPB HFB FCA : Condition for 1 cycle Step1: -55±2 30±3 min. Step2: +125±5 30±3 min. Number of cycles: 5 For FCI FHI FCH HCI : Condition for 1 cycle Step1: -40±2 30±3 min. Step2: +85±5 30±3 min. Number of cycles: 100 Measured at room temperature after placing for 2 to 3 hrs.
Low temperature storage test		Temperature: -55±2 . Duration: 1008±12hrs. Measured at room temperature after placing for 2 to 3hrs.
Drop	a: No mechanical damage b: Impedance change: ±30%	Drop 10 times on a concrete floor from a height of 75cm

### \*\*Derating Curve

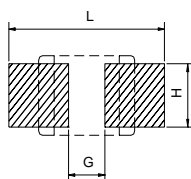
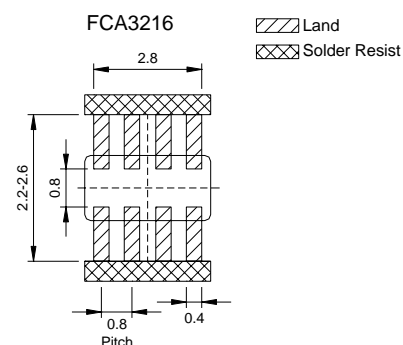
For the ferrite chip bead which withstanding current over 1.5A, as the operating temperature over 85 , the derating current information is necessary to consider with. For the detail derating of current, please refer to the Derated Current vs. Operating Temperature curve.



## 6.Soldering and Mounting

### 6-1. Recommended PC Board Pattern

Chip Size						Land Patterns For Reflow Soldering		
Series	Type	A(mm)	B(mm)	C(mm)	D(mm)	L(mm)	G(mm)	H(mm)
FCB	1005	1.0±0.10	0.50±0.10	0.50±0.10	0.25±0.10	2.10	0.50	0.55
FCM	1608	1.6±0.15	0.80±0.15	0.80±0.15	0.30±0.20	2.60	0.60	0.80
HCB	2012	2.0±0.20	1.25±0.20	0.85±0.20	0.50±0.30	3.00	1.00	1.00
HPB		2.0±0.20	1.25±0.20	1.25±0.20	0.50±0.30			
HFB	2520	2.5±0.20	2.00±0.20	1.60±0.20	0.50±0.30	3.90	1.50	1.50
FCI	3216	3.2±0.20	1.60±0.20	1.10±0.20	0.50±0.30	4.40	2.20	1.40
FHI	3225	3.2±0.20	2.50±0.20	1.30±0.20	0.50±0.30	4.40	2.20	3.40
FCH	4516	4.5±0.20	1.60±0.20	1.60±0.20	0.50±0.30	5.70	2.70	1.40
HCI	4532	4.5±0.20	3.20±0.20	1.50±0.20	0.50±0.30	5.90	2.57	4.22
UHI	5750	5.7±0.20	5.00±0.30	1.80±0.20	0.50±0.30	8.00	4.00	5.80



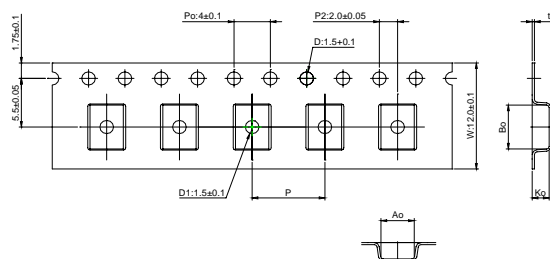
PC board should be designed so that products are not sufficient under mechanical stress as warping the board.  
Products shall be positioned in the sideways direction against the mechanical stress to prevent failure.

### 6-2. Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.



## 7-2.2 Tape Dimension / 12mm

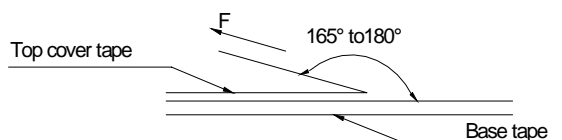


Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	t(mm)	D1(mm)
FCB,	451616	4.95±0.1	1.93±0.1	1.93±0.1	4.0±0.1	0.24±0.05	1.5±0.1
HC.B.FCM	453215	4.95±0.1	3.66±0.1	1.85±0.1	8.0±0.1	0.24±0.05	1.5±0.1
FCI	575018	6.10±0.1	5.40±0.1	2.00±0.1	8.0±0.1	0.30±0.05	1.5±0.1

## 7-3. Packaging Quantity

Chip Size	575018	453215	451616	322513	321611	201212	201209	160808	100505
Chip / Reel	1000	1000	2000	2500	3000	2000	4000	4000	10000
Inner box	4000	4000	8000	12500	15000	10000	20000	20000	50000
Middle box	20000	20000	40000	62500	75000	50000	100000	100000	250000
Carton	40000	40000	80000	125000	150000	100000	200000	200000	500000
Bulk (Bags)	7000	12000	20000	30000	50000	100000	150000	200000	300000

## 7-4. Tearing Off Force



The force for tearing off cover tape is 15 to 60 grams in the arrow direction under the following conditions.

Room Temp. ( )	Room Humidity (%)	Room atm (hPa)	Tearing Speed mm/min
5~35	45~85	860~1060	300

**Application Notice****Storage Conditions**

To maintain the solderability of terminal electrodes:

1. Temperature and humidity conditions: -10~ 40 and 30~70% RH.
2. Recommended products should be used within 6 months from the time of delivery.
3. The packaging material should be kept where no chlorine or sulfur exists in the air.

**Transportation**

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

## Impedance Frequency Characteristics(Typical)

